

1. Features

The KNX6610A is the highest performance trench N-ch MOSFETS with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications. The KNX6610A meet the RoHS and green product requirement, 100% EAS guaranteed with full function reliability approved.

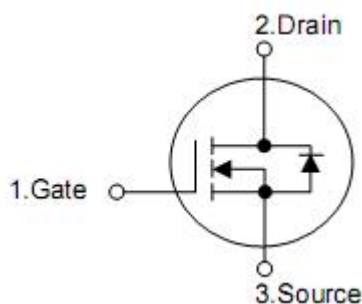
2. Features

- n $R_{DS(ON)}=70m\Omega(\text{typ.})@V_{GS}=10V$
- n Advanced high cell density trench technology
- n Super low gate charge
- n Excellent $C_{dv/dt}$ effect desline
- n Green device available

3. Applications

- n High frequency point-of-load synchronous buck converter
- n Networking DC-DC power system
- n Load switch

4.Symbol



| Pin | Function |
|-----|----------|
| 1 | Gate |
| 2 | Drain |
| 3 | Source |
| 4 | Drain |

4. Ordering Information

| Part Number | Package | Brand |
|-------------|---------|-------|
| KND6610A | TO-252 | KIA |
| KNU6610A | TO-251 | KIA |

5. Absolute maximum ratings

| Parameter | Symbol | Rating | Units |
|--|-------------------|------------|------------|
| Drain-source voltage | V_{DSS} | 100 | V |
| Gate-source voltage | V_{GS} | ± 20 | V |
| Continuous drain current, $V_{GS}@10V^1$ | $T_C=25^\circ C$ | 15 | A |
| | $T_C=100^\circ C$ | 8.5 | |
| Pulsed drain current ² | I_{DM} | 24 | |
| Power dissipation ³ | $T_C=25^\circ C$ | 34.7 | W |
| | $T_A=25^\circ C$ | 2 | |
| Single pulse avalanche energy ³ | E_{AS} | 7.3 | mJ |
| Avalanche current | I_{AS} | 11 | A |
| Operating junction and storage temperature range | T_J, T_{STG} | -55 to 150 | $^\circ C$ |

6. Thermal characteristics

| Parameter | Symbol | Typ | Max | Unit |
|-------------------------------------|-----------------|-----|-----|--------------|
| Thermal resistance junction-case | $R_{\theta JC}$ | - | 3.6 | $^\circ C/W$ |
| Thermal resistance junction-ambient | $R_{\theta JA}$ | - | 62 | |

7. Electrical characteristics

(T_J=25°C, unless otherwise noted)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
|---|-------------------------------------|--|-----|-------|------|-------|
| Drain-source breakdown voltage | BV _{DSS} | V _{GS} =0V, I _D =250μA | 100 | - | - | V |
| BV _{DSS} temperature coefficient | ΔBV _{DSS} /ΔT _J | Reference 25°C I _D =1mA | - | 0.098 | - | V/°C |
| Drain-source on-resistance ² | R _{DS(on)} | V _{GS} =10V, I _D =8A | - | 70 | 80 | mΩ |
| | | V _{GS} =4.5V, I _D =6A | - | 80 | 100 | |
| Gate threshold voltage | V _{GS(TH)} | V _{DS} = V _{GS} , I _D =250uA | 1.0 | 1.5 | 2.5 | V |
| V _{GS(TH)} temperature coefficient | ΔV _{GS(TH)} | | - | -4.57 | - | mV/°C |
| Drain-source leakage current | I _{DSS} | V _{DS} =80V, V _{GS} =0V T _J =25°C | - | - | 1 | μA |
| | | V _{DS} =80V, V _{GS} =0V T _J =55°C | - | - | 5 | |
| Gate-source forward leakage | I _{GSS} | V _{GS} =±20V, V _{DS} =0V | - | - | ±100 | nA |
| Forward transconductance | g _{fs} | V _{DS} =5V, I _D =10A | - | 13 | - | S |
| Gate resistance | R _g | V _{DS} =0V, V _{GS} =0V f=1MHz | 1.2 | 1.8 | 3.5 | Ω |
| Total gate charge(10V) | Q _g | V _{DS} =80V, I _D =10A V _{GS} =10V | - | 26.2 | - | nC |
| Gate-source charge | Q _{gs} | | - | 4.6 | - | |
| Gate-drain charge | Q _{gd} | | - | 5.1 | - | |
| Turn-on delay time | t _{d(on)} | V _{DD} =50V, I _D =10A, R _G =3.3Ω, V _{GS} =10V | - | 4.2 | - | ns |
| Rise time | t _r | | - | 8.2 | - | |
| Turn-off delay time | t _{d(off)} | | - | 35.6 | - | |
| Fall time | t _f | | - | 9.6 | - | |
| Input capacitance | C _{iss} | V _{DS} =15V, V _{GS} =0V f=1MHz | - | 1535 | - | pF |
| Output capacitance | C _{oss} | | - | 60 | - | |
| Reverse transfer capacitance | C _{rss} | | - | 37 | - | |
| Single pulse avalanche energy ⁵ | EAS | V _{DD} =25V, I _{AS} =5A L=0.1mH | 1.5 | - | - | mJ |
| Continuous source current ^{1,6} | I _S | V _D =V _G =0V, Force current | - | - | 15 | A |
| Maximum pulsed current ^{2,6} | I _{SM} | | - | - | 24 | |
| Diode forward voltage ² | V _{SD} | I _S =1A, V _{GS} =0V T _J =25°C | - | - | 1.2 | V |
| Reverse recovery time | t _{rr} | I _F =10A, di/dt=100A/μs T _J =25°C | - | 37 | - | ns |
| Reverse recovery charge | Q _{rr} | | - | 27.3 | - | nC |

Note:

1. The data tested by surface mounted on a 1 inch² board with 2OZ copper.
2. The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%.
3. The EAS data shows max. rating. The test condition is V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=11A
4. The power dissipation is limited by 150 °C junction temperature.
5. The min. value is 100% EAS tested guarantee.
6. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.

8. Typical operating characteristics

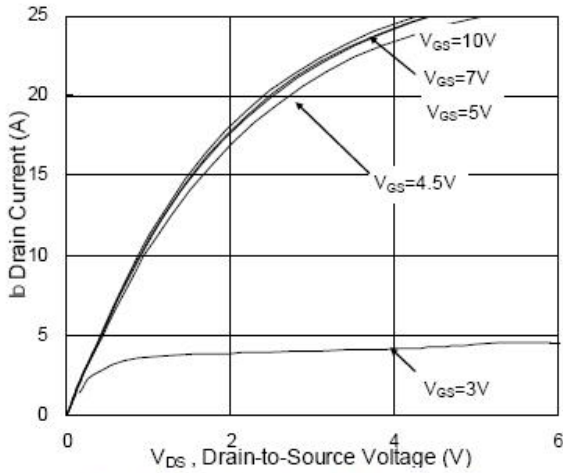


Fig.1 Typical output characteristics

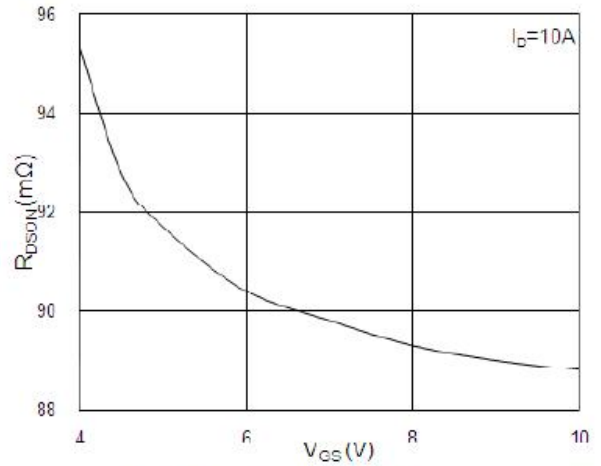


Fig.2 On-resistance vs. Gate-source

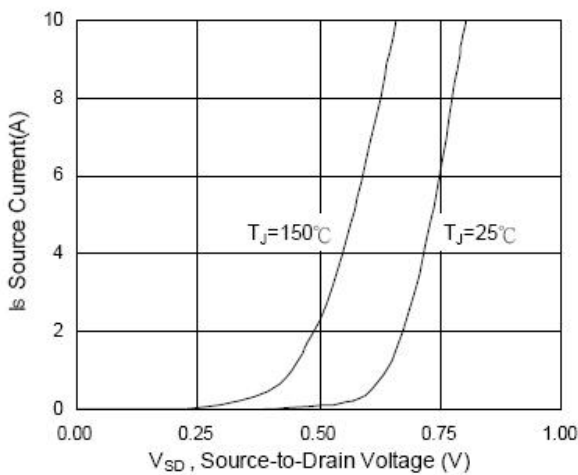


Fig.3 Forward characteristics of reverse

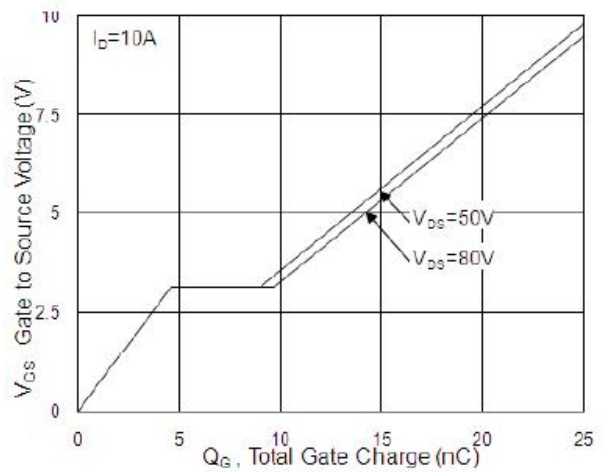


Fig.4 Gate-charge characteristics

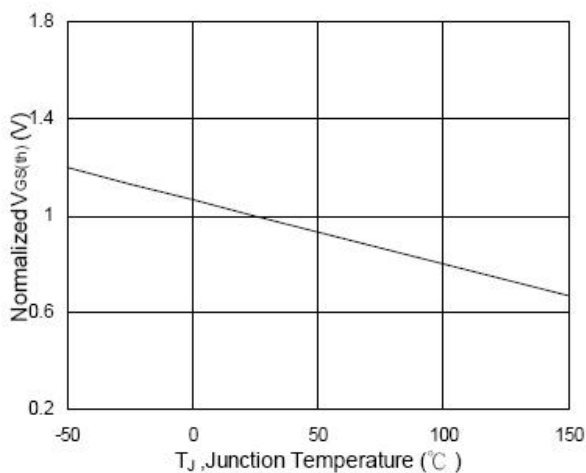


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

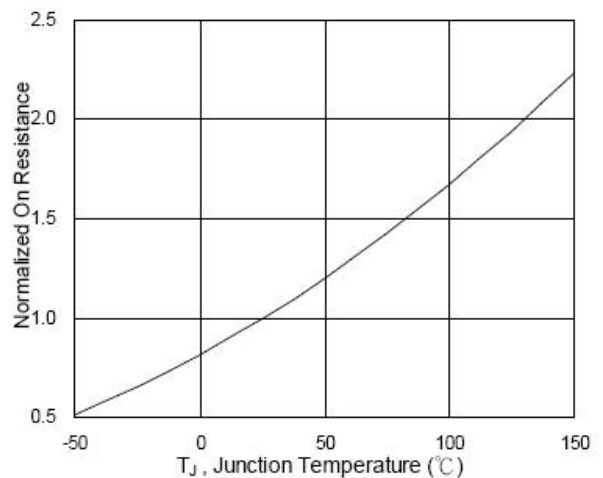


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

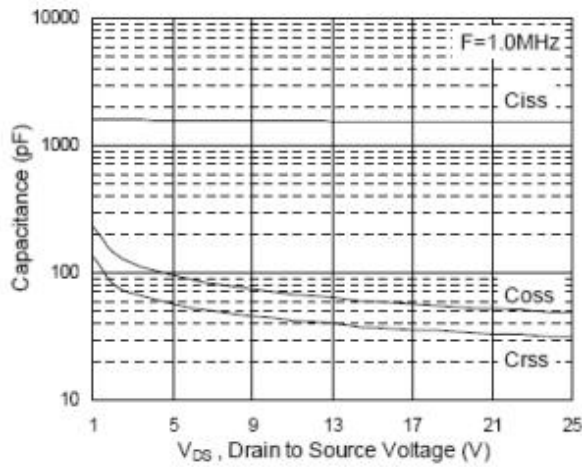


Fig.7 Capacitance

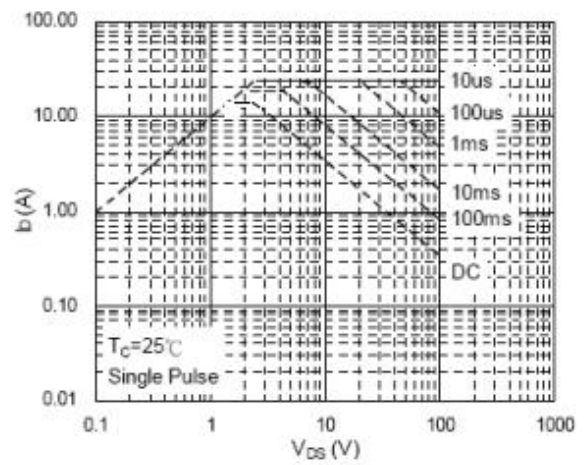


Fig.8 Safe operating area

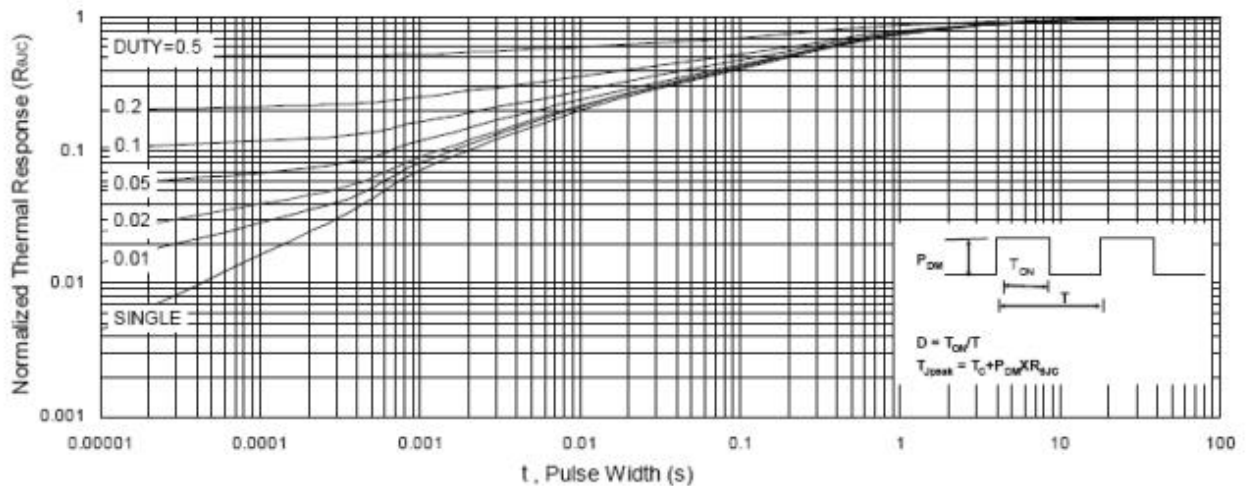


Fig.9 Normalized maximum transient thermal impedance

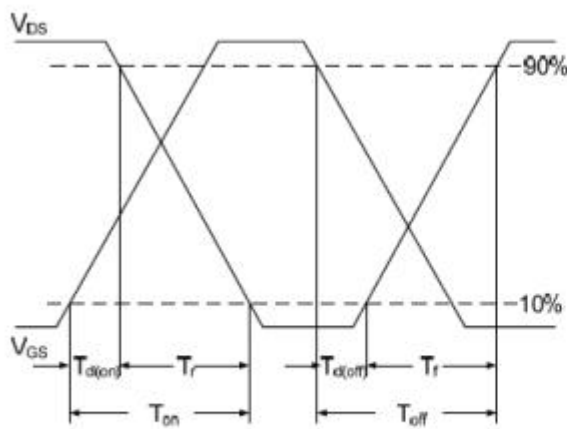


Fig.10 Switching time waveform

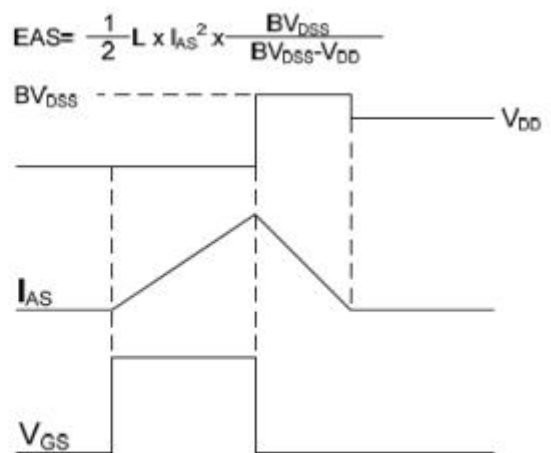


Fig.11 Gate charge waveform